Nano-Second Switching SPDT RF Switch Die M3SWA263DRC-D+

 50Ω DC to 6000 MHz Absorptive RF Switch with internal driver

The Big Deal

- High Isolation, 63 dB typ. at 1GHz
- High IIP3, +44dBm typ. at 1GHz
- Low insertion loss, 0.5 dB typ.at 1GHz
- Fast Rise/Fall time, 5.6 ns / 6 ns typ.



Product Overview

Mini-Circuits' M3SWA263DRC-D+ is a MMIC SPDT absorptive switch die with an internal driver designed for wideband operation from DC to 6 GHz supporting many applications requiring nano-second switching across a wide frequency range. This model provides excellent isolation and high linearity.

Key Features

Feature	Advantages
Wideband, DC to 6 GHz	One model can be used in many applications, saving component count. Also ideal for wideband applications such as military and instrumentation.
Absorptive switch	In the OFF condition, RF output ports which are not switched ON are terminated into 50. This enables proper impedance termination of the circuitry following the RF output ports, preventing any unintended action such as oscillation.
High Isolation: • 63 dB at 1 GHz • 29 dB at 6 GHz	High isolation significantly reduces leakage of power into OFF ports.
HHigh linearity: Pin at P1dB 26.2dBm typ. at 1GHz, Input IP3, 44dBm typ. at 1GHz	High linearity minimizes unwanted intermodulation products which are difficult or impossible to filter in multi-carrier environments such as CATV, or in the presence of strong interfering signal from adjacent circuitry or received by antenna.
Unpackaged die	Enables user to integrate it directly into hybrids.

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Typical Applications

- Defense
- Communication Infrastructure
- Test and Measurements

+RoHS Compliant The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

General Description

Mini-Circuits' M3SWA263DRC-D+ is a MMIC SPDT absorptive switch die with an internal driver designed for wideband operation from DC to 6 GHz supporting many applications requiring nano-second switching across a wide frequency range. This model provides excellent isolation and high linearity.

Simplified Schematic and Pad description



Pad#	Function
1	RF IN
3	V _{EE} (-5V)
4	RF OUT 1
6	TTL
7	TTL GROUND
9	RF OUT 2
10	VDD (+5V)
2,5,8,11 & Bottom of Die	GROUND

Bonding Pad Position



	Dimensions in µm, Typical												
L1	L2	L3	L4	H1	H2	H3	H4	H5	H6	H7	H8	H9	H10
76	408	617	733	119	290	314	450	511	607	709	733	903	1022
						P	ad Size						

Thickness	Die size	Pad Size 1,3,5,6,7,8 & 10	Pad size 2 &11	Pad size 4&9
100	733 x 1022	74 x 74	74 x 234	169 x 74

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SPDT RF Switch Die

M3SWA263DRC-D+

RF Electrical Specifications¹, T_{AMB} =25°C, 50 Ω , V_{DD} = +5V, V_{EE} = -5V

Parameter	Condition (MHz)	Min.	Тур.	Max.	Units
Frequency range ³		DC		6000	MHz
	10 - 100		0.4		
	100 - 1000		0.5		
Insertion loss	1000 - 2000		0.6		dB
	2000 - 4500		0.8		
	4500 - 6000		1.3		
	10 - 100		78		
	100 - 1000		63		
Isolation between Output Port 1 & 2	1000 - 2000		55		dB
	2000 - 4000		46		
	4000 - 4500		37		
	10 - 100		88		
	100 - 1000		77		
Isolation between Common Port & Output Ports	1000 - 2000		56		dB
	2000 - 4000		42		
	4000 - 4500		32		
	10 - 100		30		
	100 - 1000		30		
Input Return loss	1000 - 2000		29		dB
	2000 - 4000		28		
	4000 - 4500		15		
	10 - 100		30		
	100 - 1000		30		
Output Return loss (Both ON STATE & OFF STATE)	1000 - 2000		29		dB
(BOUT ON STATE & OFF STATE)	2000 - 4000		28		
	4000 - 4500		15		
	10 - 100		16.7		
	100 - 1000		24.4		
Input Power at P1dB ²	1000 - 2000		26.2		dBm
	2000 - 4000		25.6		
	4000 - 4500		25.6		
	10 - 100		38.4		
	100 - 1000		44.5		
Input IP3 (Pout=0 dBm/Tone)	1000 - 2000		46.3		dBm
	2000 - 4000		45.7		
	4000 - 4500		43.8		
Thermal Resistance - Junction-to-ground lead at 85°C stage temperature			34.2		°C/W

DC Electrical Specifications

Parameter	Min.	Тур.	Max.	Units
Positive Supply Voltage, V _{DD}	4.75	5	5.25	V
Negative Supply voltage, V _{EE}	-5.25	-5	-4.75	V
Positive Supply Current, I _{DD}	—	4	9	mA
Negative Supply Current, I _{EE}	_	3	9	mA
Control Voltage Low	—	0	0.8	V
Control Voltage High	2.3	—	5	V
Control Current Low	_	2	200	μA
Control Current High	—	0.4	5	mA

Die is packaged in 3x3mm 12L MCLP and Tested on Mini-Circuits' test board TB-M3SWA263DRC+ (See Fig.1)
 Input Power at P1dB compression drops to 11 dB at 10 MHz.
 All RF-ports must be DC blocked or held at 0V DC.

Switching Specifications

Parameter	Condition	Min.	Тур.	Max.	Units	
ON Time, 50% control to 90%	RF Pin= 0 dBm		9.3		ns	
OFF Time, 50% control to 10%	RF Pin= 0 dBm RF Freq.= 500 MHz		8.5		ns	
Video Leakage	Control Freq.= 500		25		mV	
Rise Time, 10% RF to 90% RF	KHz Control High= 2.3V Control Low= 0V		5.6		ns	
Fall Time, 90% RF to 10% RF			6.0		ns	
Gate Lag, ON & OFF			7.4		ns	

Absolute Maximum Ratings⁴

Parameter	Ratings
Operating temperature	-55°C to +100°C
RF Power Max at Input Port	27 dBm
RF Power Max at Output Port (for each port)	24 dBm
Junction Temperature	150°C
Total Power Dissipation	0.4W
DC Voltage on VDD	+6V
DC Voltage on V _{EE}	-6V

4. Permanent damage may occur if any of these limits are exceeded. Electrical Maximum ratings are not intended for continuous normal operation.

Truth Table

State of Control Voltage	RF-IN to RF-OUT 1	RF-IN to RF-OUT 2	
LOW	ON	OFF	
HIGH	OFF	ON	

Characterization & Application Circuit



Note: D1&D2 are optional.

Figure 1. Characterization & Application Circuit

Note: (DUT is packaged in 3x3mm 12L MCLP and soldered on Mini-Circuits Characterization & Application Test Board TB-M3SWA263DRC+). Insertion Loss, Amplitude Unbalance, Isolation, Return Loss, Input Power at 1dB Compression (P1dB) & Input IP3 tested using E5071C microwave network analyzer.

Condition:

1. Insertion Loss, Amplitude Unbalance, Isolation & Return Loss: Pin = 0dBm

2. Input IP3 (IIP3):Two tones, spaced 1 MHz apart, 0dBm/tone output.

Assembly Diagram



Assembly and Handling Procedure

1. Storage

Dice should be stored in a dry nitrogen purged desiccators or equivalent.

2. ESD

MMIC SPDT Absorptive Switch dice are susceptible to electrostatic and mechanical damage. Dice are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.

3. Die Attach

The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.

4. Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

Additional Detailed Technical Information

additional information is available on our dash board.

	Data Table				
Performance Data	Swept Graphs				
	S-Parameter (S2P Files) Data Set with an	nd without port extension(.zip file)			
Case Style	Die				
	Quantity, Package	Model No.			
	Small, Gel - Pak: 5,10,50,100 KGD*	M3SWA263DRC-DG+			
Die Ordering and packaging information	Medium [†] , Partial wafer: KGD*<1748 Large [†] , Full Wafer	M3SWA263DRC-DP+ M3SWA263DRC-DF+			
mormation	[†] Available upon request contact sales representative				
	Refer to AN-60-067				
Environmental Ratings	ENV80				

*Known Good Dice ("KGD") means that the dice in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such dice fall within a predefined range. While DC testing is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

ESD Rating**

Human Body Model (HBM): Class 1A (Pass 250V) in accordance with ANSI/ESD STM 5.1 - 2001 ** Tested in industry standard MCLP 3x3 mm, 12-lead package.

Additional Notes

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
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